

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SHOJI ET AL.	
		Examiner Michael V. Battaglia	Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,215,634	05-2007	Van Woudenberg, Roel	369/275.3
*	B	US-6,826,142	11-2004	Kim et al.	369/124.12
*	C	US-7,065,017	06-2006	Nishida, Norio	369/47.28
*	D	US-5,930,226	07-1999	Togawa, Yoshifusa	369/33.01
*	E	US-6,751,176	06-2004	Kanda et al.	369/53.24
*	F	US-6,301,208	10-2001	Sugaya et al.	369/47.1
*	G	US-6,278,672	08-2001	Kobayashi, Yoshihiro	369/53.23
*	H	US-6,628,584	09-2003	Heemskerk et al.	369/47.1
*	I	US-2003/0021210	01-2003	Schep, Cornelis Marinus	369/59.25
*	J	US-6,813,107	11-2004	Lee, Jeong Yeol	360/39
*	K	US-5,978,336	11-1999	Mine et al.	369/47.14
*	L	US-2004/0090886	05-2004	Sasaki, Yoshiyuki	369/047.1
*	M	US-5,634,031	05-1997	Sakuma, Hiroto	711/111

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.